

LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

ATTY. DOCKET NO.

009772-0031-999

APPLICATION NO.

09/4/96 616

APPLICANT

Waldspurger et al.

FILING DATE

September 22, 1999

U.S. PATENT DOCUMENTS

*EXAMINER INITIALS		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
MX	AA	4,821,178	04/11/89	Levin et al.	364*	200	08/15/1986
MX	AB	4,845,615	07/04/89	Blasciak	364	200	10/14/1987
MX	AC	5,103,394	04/07/92	Blasciak	395	375	12/21/1989
MX	AD	5,450,586	09/12/95	Kuzara et al.	395	700	04/30/1992
MX	AE	5,479,652	12/26/95	Dreyer et al.	395	183.06	10/21/1994
MX	AF	5,485,574	01/16/96	Bolosky et al.	395	183.11	11/04/1993
MX	AG	5,493,673	02/20/96	Rindos, III et al.	395	550	03/24/1994
MX	AH	5,528,753	06/18/96	Fortin	395	183.11	06/30/1994
MX	AI	5,537,541	07/16/96	Wibecan	395	183.21	08/16/1994
MX	AJ	5,572,672	11/05/96	Dewitt et al.	395	184.01	07/12/1995
MX	AK	5,581,482	12/03/96	Wiedenman et al.	364	551.01	04/26/1994
MX	AL	5,651,112	07/22/97	Matsuno et al.	395	184.01	02/22/1996
MX	AM	5,796,939	08/18/98	Berc et al.	395	184	03/10/1997
MX	AN	5,809,450	09/15/98	Chrysos et al.	702	186	11/26/1997
MX	AO	5,857,097	01/05/99	Henzinger et al.	395	583	03/10/1997
MX	AP	5,923,872	07/13/99	Chrysos et al.	395	591	11/26/1997
MX	AQ	5,964,867	10/12/99	Anderson et al.	712	219	11/26/1997
MX	AR	6,000,044	12/07/99	Chrysos et al.	714	47	11/26/1997
MX	AS	6,009,514	12/28/99	Henzinger et al.	712	236	10/30/1998
MX	AT						
MX	AU						
MX	AV						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
MX	AW							
	AX							
	AY							
	AZ							

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages)

MX	BA	Calder, B. <i>et al.</i> , "Value Profiling," Proceedings Thirtieth Annual IEEE/ACM International Symposium on Microarchitecture, December 1997, pp.259-269.
MX	BB	Dean, J., <i>et al.</i> , "ProfileMe: Hardware Support for Instruction-Level Profiling on Out-of-Order Processors," 1997, IEEE, Published in the Proceedings of Micro-30, December 1997, 12 pages.
MX	BC	Anderson, J.M., "Continuous Profiling: Where have all the Cycles Gone?," Thirtieth Annual IEEE/ACM International Symposium on Microarchitecture, December 1-3, 1997, pp.1-20; Also appeared in the 16 th ACM Symposium on Operating System Principles, October 5-8, 1997.
MX	BD	Gibbons, P.B., <i>et al.</i> , "New Sampling-Based Summary Statistics for Improving Approximate Query Answers," Proc.ACM SIGMOD, 1998.
MX	BE	Lipasti, M.H., <i>et al.</i> , "Value Locality and Load Value Prediction," Seventh International Conference on Architectural Support for Programming Languages and Operating Systems, October 1996.
MX	BF	Lipasti, M.H., <i>et al.</i> , "Exceeding the Dataflow Limit via Value Prediction," Proceedings of the 29 th Annual Symposium on Microarchitecture, December 1996.
MX	BG	Dean, Jeffrey, <i>et al.</i> , "Transparent, Low-Overhead Profiling on Modern Processors," Compaq Computer Corporation, 3 pgs.
MX	BH	Anderson, Jennifer M., <i>et al.</i> , Digital: SRC Technical Note 1997-016a, "Continuous Profiling: Where Have All the Cycles Gone?," 1p. Available Web Site: http://gatekeeper.dec.com/pub/DEC/.tes/abstracts/src-tn-1997-016.html ; Modified Sept. 3, 1997.
MX	BI	Anderson, Jennifer M., <i>et al.</i> , Digital SRC, Continuous Profiling - Abstract for HotChips9 Presentation, "Continuous Profiling: (It's 10:43; Do you Know Where Your Cycles Are?," 1-2. Accessed 3/24/2000. Available Web Site: http://www.research.digital.com/SRC/dcp/papers/hotchips9-abstract.html .
MX	BJ	Weihl, William E., Digital Systems Research Center, CPI: Continuous Profiling Infrastructure, "Digital Continuous Profiling Infrastructure," 1-3. Available Web Site: http://www.research.digital.com/SRC/articles/199703/dcp.html , Last modified December 7, 1999.
MX	BK	Digital Equipment Corporation (1996, 1997). Digital Continuous Profiling Infrastructure Project, "Digital Continuous Profiling Infrastructure, HotNews V2.11 Available!," 1-1. Available Web Site: http://www.research.digital.com/SRC/dcp/ . Last modified Sept. 10, 1998.
MX	BL	Berc, Lance, <i>et al.</i> , Digital Continuous Profiling Infra... '96 Work-In-Progress Presentation. "Digital Continuous Profiling Infrastructure," 1-2. Available Web Site: http://www.research.digital.com/SRC/dcp/papers/osdi96-wip.html , Last modified May 5, 1997.
MX	BM	Digital Equipment Corporation (1996, 1997). Documentation: Digital Continuous Profiling Infrastructure, "Documentation," 1-3. Available Web Site: http://www.research.digital.com/SRC/dcp/documentation.html , Last modified Dec. 2, 1997.
MX	BN	Digital Equipment Corporation (1996, 1997). Publications and Talks: Digital Continuous Profiling Infrastructure, "Publications and Talks," 1-2. Available Web Site: http://www.research.digital.com/SRC/dcp/pubs-and-talks.html . Last modified Feb. 2, 1999.
MX	BO	Weihl, William E., Digital Systems Research Center. CPI: Continuous Profiling Infrastructure, "Digital Continuous Profiling Infrastructure," 1-3. Available Web Site: http://www.research.digital.com/SRC/articles/199703/dcp.html . Last modified March 25, 1997.

EXAMINER

[Signature]

DATE CONSIDERED

7-1-02

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.